

Notice of References Cited	Application/Control No. 10/619,434	Applicant(s)/Patent Under Reexamination BEHFAR, ALEX A.	
	Examiner: John D. Lee <i>John D. Lee</i>	Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,807,953	02-1989	Smith et al.	385/27
*	B	US-4,829,528	05-1989	Band et al.	372/3
*	C	US-5,027,361	06-1991	Kozlovsky et al.	372/22
*	D	US-2002/0063944	05-2002	Kim et al.	359/326
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	8-186540	07-1996	Japan	Furukawa	H04B 10/152
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.